

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10580517	YE, JONG CHUL
	Examiner HEE-YONG KIM	Art Unit 2621

SEARCHED

Class	Subclass	Date	Examiner
375	240.08	7/20/2010	H.K

SEARCH NOTES

Search Notes	Date	Examiner
Inventor serach at Edan	7/19/2010	H.K
scalable (coding or encoding) and (rate distortion with runlength with pair)	7/19	H.K
(scalable near2 (cod\$3 or encod\$)) and rate distortion	7/19	H.K
(scalable near2 (cod\$3 or encod\$)) and rate distortion and (vlc with base layer)	7/19	H.K
(scalable near2 (cod\$3 or encod\$)) and rate distortion and (distortion with run\$7 with pair)	7/19	H.K
(scalable near2 (cod\$3 or encod\$)) and rate distortion and ((distortion or cost or lagrangian) with (coefficient or run or pair))	7/19	H.K
scalable near2 (cod\$3 or encod\$)) and rate distortion and ((distortion or cost or lagrangian) with (macroblock) and DCT	7/19	H.K
MPEG\$2 and (rate distortion or rate-distortion) and exponential	7/20	H.K
MPEG\$2 and (rate distortion or rate-distortion) and exponential and (DCT with quantiz\$5)	7/20	H.K
NPL search (MPEG and exponential R-D)	7/20	H.K

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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